

85X PSB5 G Page 1 of 4 July 2019

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CERTIFICATE OF ANALYSIS

85X PSB5 (batch G)

Certified Reference Material Information

Type: LEAD / ANTIMONY ALLOY (CAST)

Form and Size: Disc ~40mm diameter

Produced by: Universal Scientific Laboratory, Australia

Certified and supplied by: MBH Analytical Ltd

Assigned Values

Percentage element by weight

Element	Sb	Sn	Bi	Cu	Ni	As
Value ¹	4.72	0.288	0.0124	0.0526	0.0008	0.248
Uncertainty ²	0.04	0.005	0.0004	0.0008	0.0001	0.005

Element	Cd	Ag	Se	Te	S	Zn
Value ¹	0.00055	0.0029	0.0137	0.0016	0.010	0.0003
Uncertainty ²	0.00006	0.0001	0.0013	0.0002	0.002	0.0001

Note: values given in parentheses are not certified - they are provided for information only.

Definitions

- The certified values are the present best estimates of the true content for each element. Each value is a panel consensus, based on the averaged results of an interlaboratory testing programme, detailed on page 3.
- The uncertainties are value judgements, based on the 95% confidence interval derived from the wet analysis results, in combination with a statistical assessment of the homogeneity data, as described on page 2.

Certified by	:
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MBH ANALYTICAL LIMITED		on 22nd July 2019
	C Eveleigh	

Method of Preparation

This reference material was produced from commercial lead, plus pure elements and master alloys, resistance-melted under an inert gas cover. The melt was cast by sequential transfer of aliquots into iron moulds. 2mm has been removed from the working face to minimise any surface effects.

Sampling

Samples for chemical analysis were taken from various positions throughout the casting process. Approximately 10% of all discs were selected for non-destructive homogeneity testing.

Homogeneity

The discs were checked for sample and batch uniformity using an optical emission spectrometer.

Using the combined data for each surface, through-batch variation values were derived for each element as an indicator of any minor compositional variation (as determined for the specific sample size and other limitations of the spectrometer).

Chemical Analysis

Analysis was carried out on millings taken from samples representative of the product. It was performed by a panel of laboratories mostly operating within the terms of EN ISO/IEC 17025, using documented standard reference methods and validated by appropriate reference materials.

The individual values listed overpage are the average of each analyst's results.

Estimation of Uncertainties

Each element certified has been analysed by several laboratories, and 95% half-width confidence intervals ($C_{(95\%)}$) for the resultant mean values have been derived by the method shown on page 3.

As a separate exercise, the degree of non-homogeneity of the batch for each element has been quantified by a programme of non-destructive application testing, discussed above.

The final certified uncertainty for each element has been derived by combining these two factors, using the square-root of the summed squares.

Traceability

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials.

Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

<u>Usage</u>

Intended use: With optical emission and X-ray fluorescence spectrometers.

Recommended method of use:

Lead and its alloys are generally prepared by machining on a lathe. However, users are recommended to follow the calibration and sample preparation procedures specified by the relevant instrument manufacturer.

Preparation should be the same for reference materials and the samples for test.

A minimum of five consistent replicate analyses is recommended to provide the necessary sample size. Users are advised to check against possible bias between reference materials and production samples due to differences in metallurgical history, and be aware of possible inter-element effects.

Analytical Data

Percentage element by weight

Sample	Sb	Sn	Bi	Cu	Ni	As
1	4.640	0.2740	0.0106	0.0499	0.00058	0.2349
2	4.642	0.2762	0.0118	0.0501	0.00060	0.2392
3	4.656	0.2790	0.0122	0.0507	0.00070	0.2395
4	4.661	0.2810	0.0122	0.0517	0.00074	0.2440
5	4.664	0.2817	0.0122	0.0519	0.00075	0.2450
6	4.676	0.2830	0.0122	0.0522	0.00080	0.2480
7	4.707	0.2875	0.0122	0.0522	0.00080	0.2515
8	4.727	0.2877	0.0123	0.0527	0.00080	0.2517
9	4.730	0.2908	0.0125	0.0530	0.00081	0.2528
10	4.739	0.2909	0.0126	0.0531	0.00083	0.2530
11	4.770	0.2911	0.0126	0.0532	0.00088	0.2530
12	4.774	0.2916	0.0127	0.0536	0.00090	0.2535
13	4.780	0.2930	0.0128	0.0537	0.00092	0.2540
14	4.788	0.2940	0.0128	0.0541		0.2552
15	4.790	0.2944	0.0132	0.0545		
16		0.2970	0.0139	0.0556		
17		0.3000				
Mean	4.716	0.2878	0.0124	0.0526	0.00078	0.2482
Std Dev	0.056	0.0075	0.0007	0.0016	0.00010	0.0066
C _(95%)	0.031	0.0040	0.0004	0.0008	0.00006	0.0038
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Sample	Cd	Ag	Se	Te	\$	Zn
1	0.00040	0.00250	0.0111	0.00130	0.0069	0.00014
2	0.00040	0.00251	0.0114	0.00130	0.0070	0.00015
3	0.00045	0.00258	0.0127	0.00133	0.0083	0.00020
4	0.00046	0.00270	0.0132	0.00140	0.0084	0.00026
5	0.00050	0.00273	0.0135	0.00148	0.0105	0.00030
6	0.00050 0.00050	0.00278 0.00280	0.0136 0.0143	0.00148 0.00150	0.0108 0.0111	0.00031 0.00032
7 8	0.00054	0.00280	0.0143	0.00150	0.0111	0.00032
_	0.00057	0.00207	0.0157	0.00131	0.0113	0.00040
9 10	0.00060	0.00298	0.0162	0.00177	0.0132	0.00044
11	0.00060	0.00290	0.0102	0.00177	0.0132	0.00050
11 12	0.00063	0.00305		0.00200		0.00030
13	0.00070	0.00306		0.00200		
13 14	0.00070	0.00310		0.00210		
15	0.00070	0.00310		0.00210		
16	0.00010	0.00320				
Mean	0.00055	0.00288	0.0137	0.00163	0.0099	0.00031
Std Dev	0.00010	0.00024	0.0017	0.00028	0.0021	0.00012
	0.00010	0.00024	0.0017	0.00028	0.0021	0.00012
C _(95%)	0.00000	0.00013	0.0012	0.00010	0.0013	0.00006

Note: $C_{(95\%)}$ is the 95% half-width confidence interval derived from the equation:

 $C_{(95\%)} = (t \times SD)/\sqrt{n}$

where n is the number of available values, t is the Student's t value for n-1 degrees of freedom, and SD is the standard deviation of the test results.

Participating Laboratories

Sheffield Analytical Services Anchorcert Analytical Universal Scientific Laboratory Pty Ltd Genitest, Inc Shanghai Jinyi Test Tech Co Luo Yang Copper Raghavendra SpectroMet Laboratory Institute of Non-Ferrous Metals Tec-Eurolab TCR Engineering Services Ltd Mineral & Metallurgical Laboratories **INCDMNR-IMNR** AMG Superalloys UK Ltd AIM Metals and Alloys LP Laboratory Inppamet Scrooby's Laboratory Service Analyticka Laborator Lithea sro

Sheffield, England Birmingham, England Milperra, NSW, Australia Montreal, Canada Shanghai, China Luo Yang, He Nan, China Bangalore, India Gliwice, Poland Campogalliano, Italy Mumbai, India Bangalore, India Pantelimon, Romania Rotherham, England Montreal, QC, Canada Calama, Chile Benoni, South Africa Brno, Czech Republic

UKAS accreditation 0012 UKAS accreditation 0667 NATA accreditation 0492 PJ accreditation L17-153 CNAS accreditation L0041 CNAL accreditation 0173 NABL accreditation T371 PCA accreditation AB274 ACCREDIA accreditation 52

Note: to achieve the above accreditation (UKAS, etc), test houses must demonstrate conformity to the general requirements of EN ISO/IEC 17025.

Analytical Methods Used

ELEMENT	RESULT No. & METHOD					
	ICP-AES	ICP-MS	FAAS		OTHER	
Antimony	1-4, 6-8, 10, 11, 13, 14	-	5, 15	9	photometric (crystal violet)	
				12	volumetric (bromate)	
Tin	1-3, 5-8, 10-13, 15	-	4, 9, 14, 17	16	volumetric (iodide)	
Bismuth	1-3, 5, 6, 8, 10-13, 16	7	9, 14	4, 15	photometric (iodide)	
Copper	1-3, 5, 8-10, 12, 14, 15	7	4, 11, 13, 16	6	volumetric (thiosulfate)	
Nickel	1-3, 5-9, 12	11	4, 10, 13			
Arsenic	1-9, 11, 14	12	10	13	photometric (molybdenum blue)	
Cadmium	1-3, 5-7, 10-13	8	4, 9, 14, 15			
Silver	2, 4-9, 11, 14	10	1, 3, 12, 13, 16	15	photometric (dithizone)	
Selenium	1, 2, 4, 6-9	3	5, 10			
Tellurium	1-5, 7-12, 14	-	6, 13			
Sulfur	1, 8, 10	-	-	others	combustion (IR detection)	
Zinc		-	1, 4, 5, 9		·	

Notes

This Certified Reference Material has been produced and certified, wherever possible, in accordance with the requirements of ISO17034, taking into account the requirements of the ISO Guide to the Expression of Uncertainty in Measurement (GUM).

The unidirectional solidification effects associated with this method of casting have led to the formation of inhomogeneous segregates in the rear portion of the disc. The above certification is therefore only applicable from the front face of the disc, to a depth of 10mm. Material to the rear of the disc, to a depth of ~5mm, is not certified.

This material is liable to superficial corrosion. There is also a possibility for microstructural changes due to recrystallisation, and diffusion effects may lead to the concentration of some elements at the surface. For X-ray and other superficial sampling techniques, it is therefore recommended that the surface is refreshed immediately prior to use. In all other respects, this sample will remain stable indefinitely, provided adequate precautions are taken to protect it from cross-contamination, extremes of temperature and atmospheric moisture.

All production records will be retained for a period of 20 years from the date of this certificate. Technical support for this certification will therefore expire in July 2039, although we reserve the right to make changes as issue revisions, in the intervening period.

This sample is also available in the form of chippings.

The manufacture, analysis and certification of this product were supervised by C Eveleigh, PhD, Technical Director, MBH Analytical Ltd.

The material to which this certificate of analysis refers is supplied subject to our general conditions of sale.